#### AMENDMENT TO THE CLAIMS:

This listing of claims will replace all prior versions of claims in the application:

### LISTING OF CLAIMS:

- 1. (CURRENTLY AMENDED) A system for lapping a head, comprising:
- (a)—a wafer including at least one head each having an electrical lapping guide (ELG), a plurality of wafer contacts in electrical communication with the ELG, and a closure formed thereon defining a slot in which the wafer contacts are positioned;
- (b)——a lapping cable coupled to a testing device, the lapping cable including a plurality of lapping cable contacts; and
- (e)—an adapter including a plurality of adapter contacts in electrical communication with the lapping cable contacts;
- (d) wherein the adapter contacts are removably positionable in electrical communication with the wafer contacts during a lapping process.
- (ORIGINAL) The system as recited in claim 1, wherein the adapter is constructed from a polyimide material.
- 3. (PREVIOUSLY PRESENTED) The system as recited in claim 1, wherein the adapter includes a pair of holes formed therein for coupling with a pair of holes formed in the lapping cable via a pair of alignment pins.
- 4. (ORIGINAL) The system as recited in claim 1, wherein the adapter includes at least one guide for being removably positioned in a slot defined by closures of adjacent heads formed on the wafer.

- (ORIGINAL) The system as recited in claim 1, wherein the adapter contacts are slidably coupled to the adapter.
- 6. (ORIGINAL) The system as recited in claim 1, wherein the adapter contacts each include a first portion in electrical communication with one of the lapping cable contacts and a second portion in electrical communication with one of the wafer contacts.
- (ORIGINAL) The system as recited in claim 6, wherein the first portion of each adapter contact is larger than the second portion of each adapter contact.
- (ORIGINAL) The system as recited in claim 7, wherein the first portion of each adapter contact has a diameter larger than that of the second portion of each adapter contact.
- (ORIGINAL) The system as recited in claim 6, wherein the adapter includes a
  recess for preventing contact with the wafer during the lapping process.

# 10-13. (CANCEL)

14. (ORIGINAL) An apparatus for use with a wafer including at least one head each having an electrical lapping guide (ELG), a plurality of wafer contacts in electrical communication with the ELG, and a closure formed thereon defining a slot in which the wafer contacts are positioned, and a lapping cable coupled to a testing device, the lapping cable including a plurality of lapping cable contacts; the apparatus comprising: an adapter including a plurality of adapter contacts in electrical communication with the lapping cable contacts, wherein the adapter contacts are removably positionable in electrical communication with the wafer contacts during a lapping process.

## 15. (CANCEL)

16. (CURRENTLY AMENDED) An adapter including a plurality of adapter contacts adapted for electrical communication with a plurality of lapping cable contacts of a lapping cable, wherein the adapter contacts are removably positionable in electrical communication with a plurality of wafer contacts of a wafer during a lapping process, the wafer including at least one head each having an electrical lapping guide (ELG), the wafer contacts being in electrical communication with the ELG, and a closure extending from a surface in which the wafer contacts are positioned.

# 17-19. (CANCEL)

- 20. (CURRENTLY AMENDED) A system for lapping a head, comprising:

  a wafer including at least one head each having an electrical lapping guide

  (ELG), the wafer contacts being in electrical communication with the ELG, and a closure extending from a surface in which the wafer contacts are positioned;
- (a)—a lapping cable coupled to a testing device, the lapping cable including a plurality of lapping cable contacts; and
- (b) an adapter including a plurality of adapter contacts in electrical communication with the lapping cable contacts;
- (e) wherein the adapter contacts are removably positionable in electrical communication with <u>the contacts on a the wafer during a lapping process.</u>